

**Search Notes**

Application/Control No.

10/686,729

Examiner

Jean W. Désir

Applicant(s)/Patent under  
Reexamination

LEE, YONG-HYUN

Art. Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	565 563 564	3/22/2007	<i>JWD</i>
	584, 588		
	598, 705		
	220.1		
	222.1 239		
	14.11		
382	284		
358	450		
345	630		
	629		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/22/2007	<i>JWD</i>

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
348	584, 705	3/26/2007	
	220.1		
	222.1 598		